

## WNM3032

**Single N-Channel, 30V, 9.6A , Power MOSFET**

[Http://www.willsemi.com](http://www.willsemi.com)

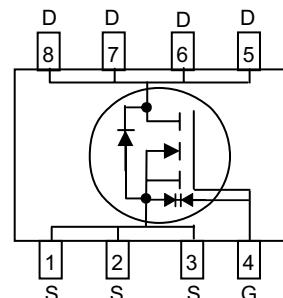
<b>V<sub>DS</sub> (V)</b>	<b>R<sub>DS(on)</sub> (mΩ)</b>
30	8.5@ V <sub>GS</sub> = 10V
	12@ V <sub>GS</sub> = 4.5V
ESD Protected	



## Descriptions

The WNM3032 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS (ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM3032 is Pb-free.

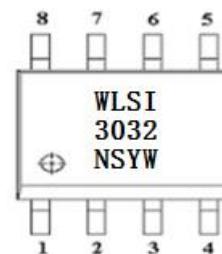
**SOP-8L**



## Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOP-8L

**Pin configuration (Top view)**



WLSI = Company  
 3032 = Device Code  
 NS = Special Code  
 YW = Date Code

## Applications

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

## Marking

## Order information

Device	Package	Shipping
WNM3032-8/TR	SOP-8L	4000/Reel&Tape

## Absolute Maximum ratings

<b>Parameter</b>		<b>Symbol</b>	<b>10 s</b>	<b>Steady State</b>	<b>Unit</b>
Drain-Source Voltage		V <sub>DS</sub>		30	V
Gate-Source Voltage		V <sub>GS</sub>		±20	
Continuous Drain Current <sup>a d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	12.9	9.6	A
	T <sub>A</sub> =70°C		10.3	7.7	
Maximum Power Dissipation <sup>a d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	3.0	1.7	W
	T <sub>A</sub> =70°C		1.9	1.1	
Continuous Drain Current <sup>b d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	9.3	7.5	A
	T <sub>A</sub> =70°C		7.4	6.0	
Maximum Power Dissipation <sup>b d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	1.5	1.0	W
	T <sub>A</sub> =70°C		1.0	0.6	
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>		50	A
Operating Junction Temperature		T <sub>J</sub>		-55 to 150	°C
Lead Temperature		T <sub>L</sub>		260	°C
Storage Temperature Range		T <sub>stg</sub>		-55 to 150	°C

## Thermal resistance ratings

<b>Parameter</b>		<b>Symbol</b>	<b>Typical</b>	<b>Maximum</b>	<b>Unit</b>
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 10 s	R <sub>θJA</sub>	32	42	°C/W
	Steady State		59	75	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t ≤ 10 s	R <sub>θJA</sub>	59	81	°C/W
	Steady State		95	125	
Junction-to-Case Thermal Resistance	Steady State	R <sub>θJC</sub>	35	45	

a Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper

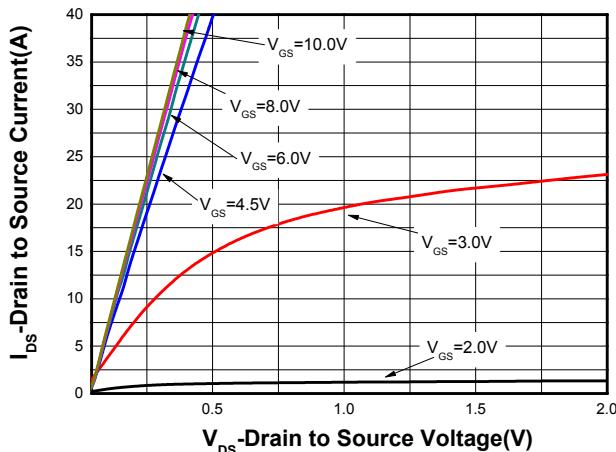
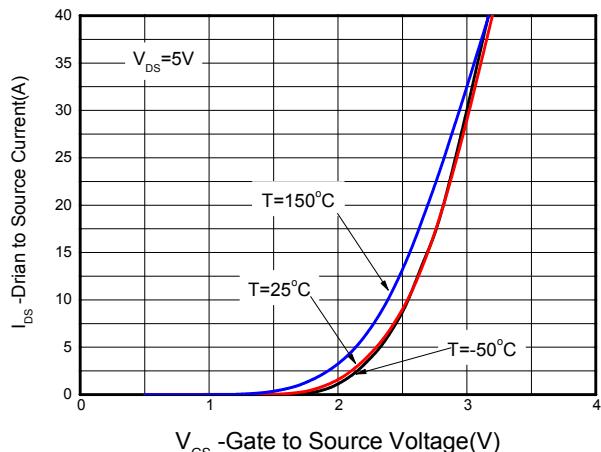
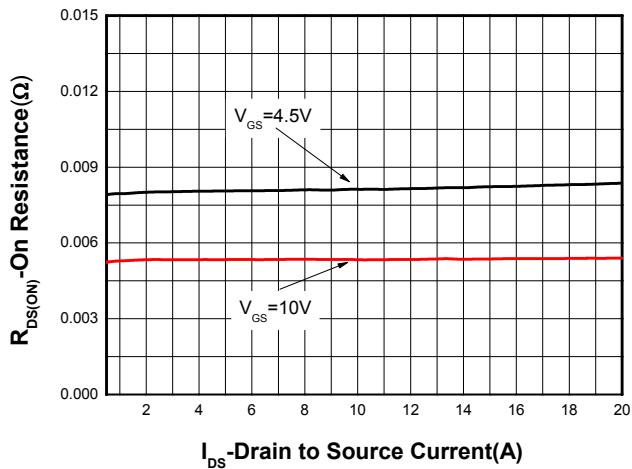
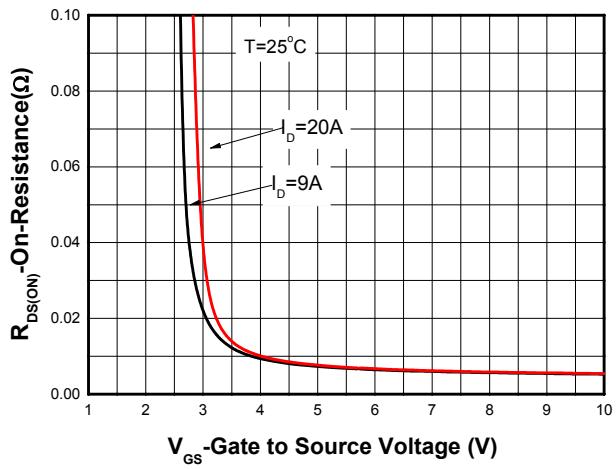
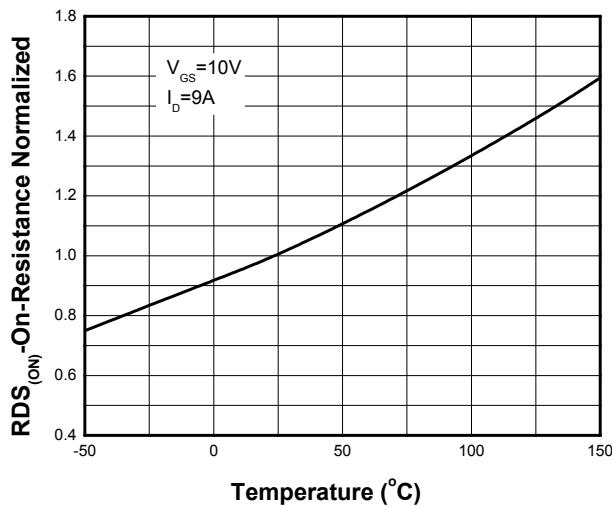
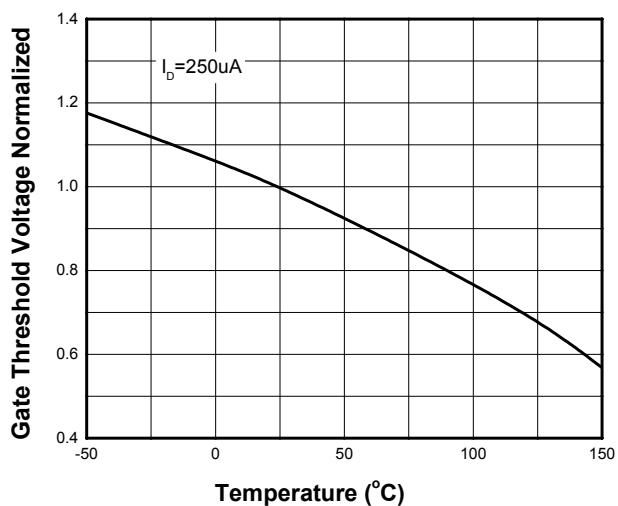
b Surface mounted on FR4 board using minimum pad size, 1oz copper

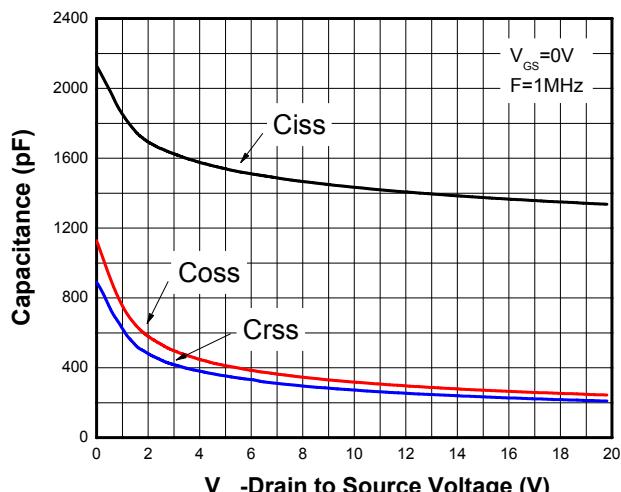
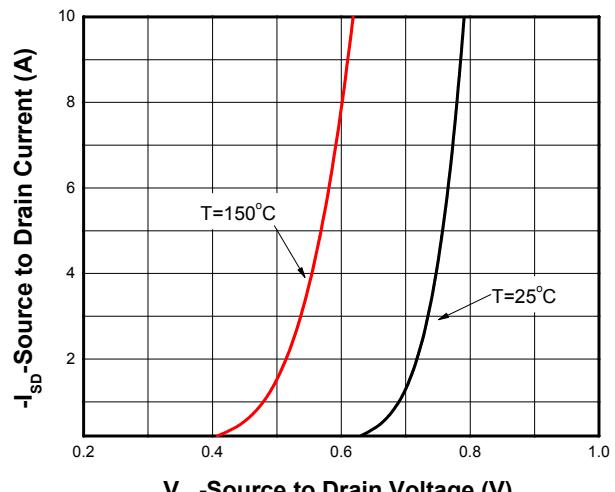
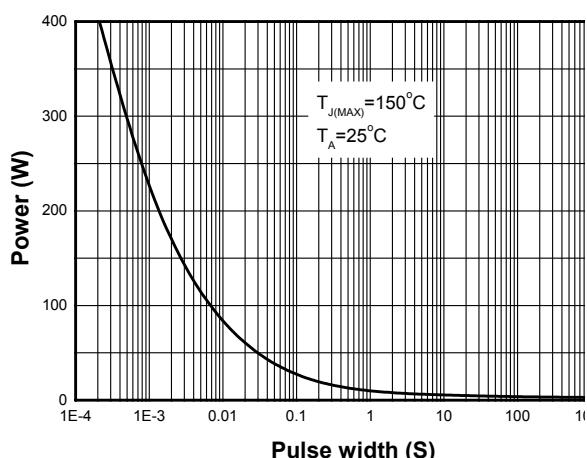
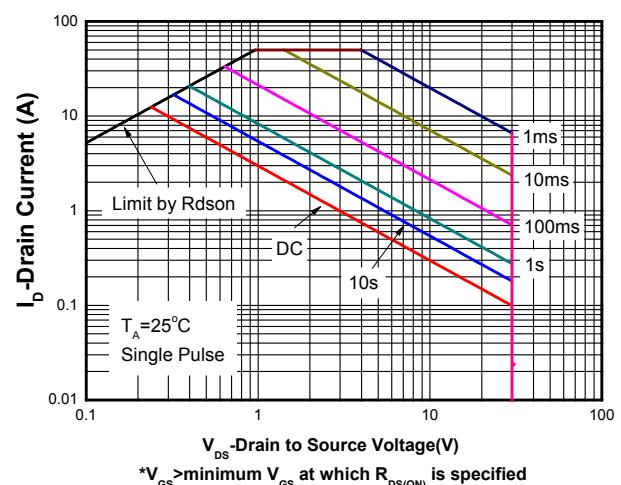
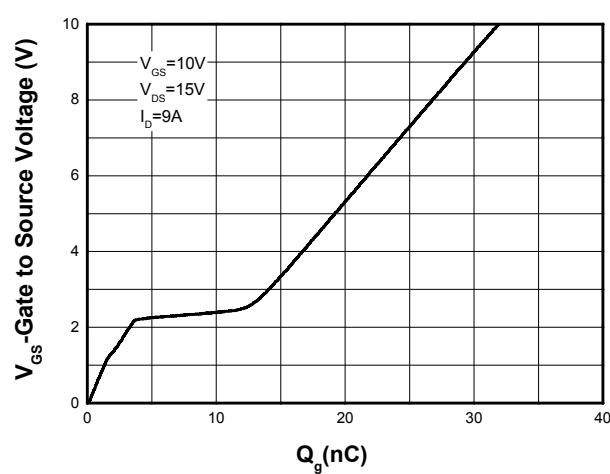
c Repetitive rating, pulse width limited by junction temperature, t<sub>p</sub>=10µs, Duty Cycle=1%

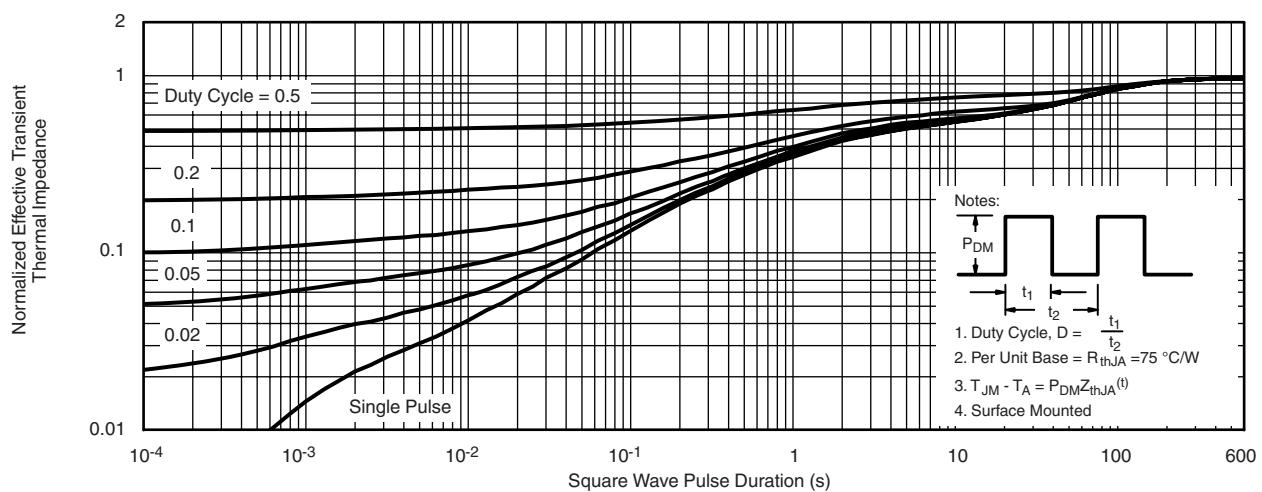
d Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>=150°C.

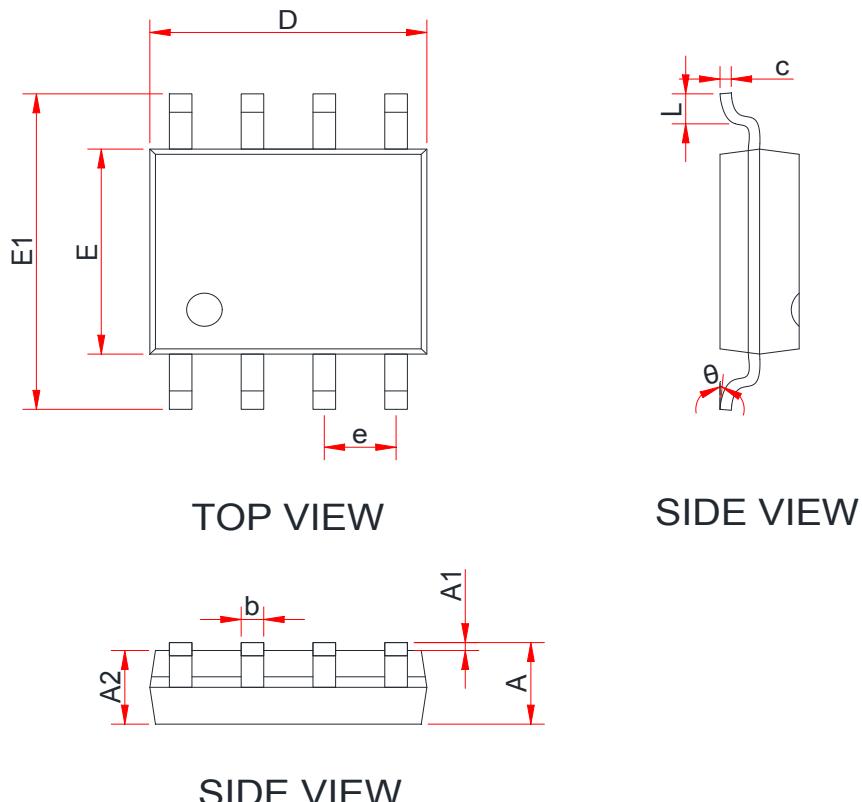
**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250uA	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0V			1	uA
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20V			±5	uA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250uA	1.0	1.4	2.0	V
Drain-to-source On-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10A		8.5	12	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8A		12	16	
<b>CHARGES, CAPACITANCES AND GATE RESISTANCE</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, F = 1.0 MHz, V <sub>DS</sub> = 15 V		1375		pF
Output Capacitance	C <sub>OSS</sub>			271		
Reverse Transfer Capacitance	C <sub>RSS</sub>			233		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10A		28.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			1.3		
Gate-to-Source Charge	Q <sub>GS</sub>			4.3		
Gate-to-Drain Charge	Q <sub>GD</sub>			5.48		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	td(ON)	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, R <sub>G</sub> = 3 Ω, R <sub>L</sub> = 0.75Ω		13.8		ns
Rise Time	tr			10.2		
Turn-Off Delay Time	td(OFF)			63.2		
Fall Time	tf			12.4		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1A	0.5	0.7	1.2	V

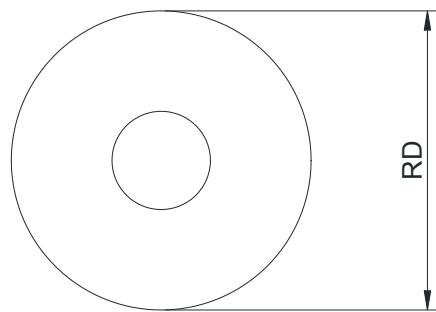
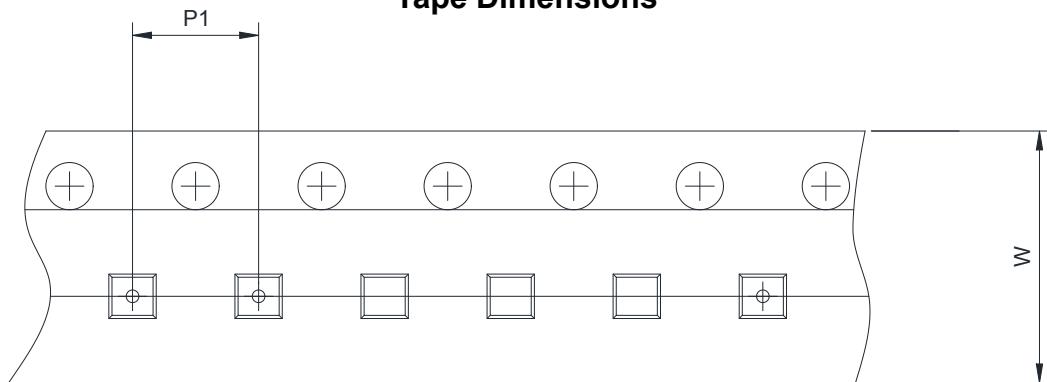
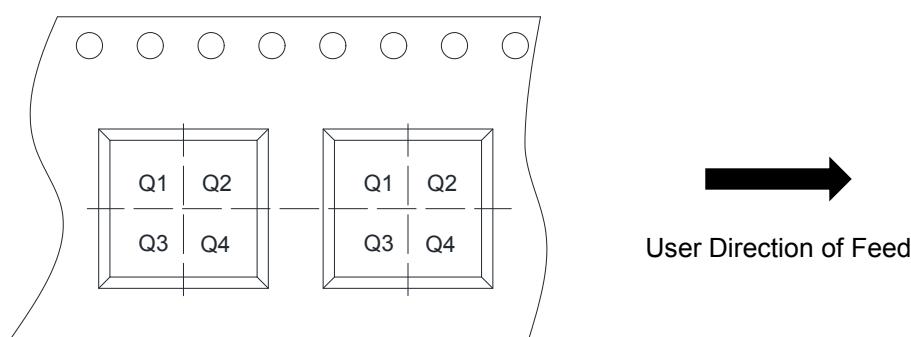
**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**


**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Package outline dimensions**
**SOP-8L**


Symbol	Dimensions In Millimeters (mm)		
	Min.	Typ.	Max.
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
A2	1.25	1.40	1.65
b	0.33	-	0.51
c	0.15	-	0.26
D	4.70	4.90	5.10
E	3.70	3.90	4.10
E1	5.80	6.00	6.20
e	1.27BSC		
L	0.40	-	1.27
θ	0°	-	8°

**TAPE AND REEL INFORMATION**
**Reel Dimensions**

**Tape Dimensions**

**Quadrant Assignments For PIN1 Orientation In Tape**


RD	Reel Dimension	<input type="checkbox"/> 7inch <input checked="" type="checkbox"/> 13inch
W	Overall width of the carrier tape	<input type="checkbox"/> 8mm <input checked="" type="checkbox"/> 12mm
P1	Pitch between successive cavity centers	<input type="checkbox"/> 2mm <input type="checkbox"/> 4mm <input checked="" type="checkbox"/> 8mm
Pin1	Pin1 Quadrant	<input checked="" type="checkbox"/> Q1 <input type="checkbox"/> Q2 <input type="checkbox"/> Q3 <input type="checkbox"/> Q4